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TEST REPORT

FCC Part 22 Subpart H

Report Reference No.: **CTL2506062031-WF01**

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Product Name: Camera

Model/Type reference: MDPT3301LE

MDPT2301LE, MDPT2302LE, MDPT2303LE, MDPT3302LE,

List Model(s): MDPT3303LE, MDPT3401LE, MDPT3402LE, MDPT3403LE, MDPT5801LE, MDPT5802LE, MDPT5803LE, T10, T20, T30, T40, T50, T60, T12

Trade Mark: N/A

FCC ID: **2BRPK-M3301**

Applicant's name: **MAYON ELECTRONIC TECHNOLOGY CO.,LTD**

Address of applicant: Area A01, 4th Floor, Building 1, No. 15, Pingbei 2nd Road, Nanping, Xiangzhou District, Zhuhai City, China

Test Firm: **Shenzhen CTL Testing Technology Co., Ltd.**

Address of Test Firm: Floor 1-A, Baisha Technology Park, No.3011, Shahexi Road, Nanshan District, Shenzhen, China 518055

Test specification:

Standard: **FCC Part 22 Subpart H**
ANSI/TIA/EIA-603-E:2016
KDB 971168 D01

TRF Originator: Shenzhen CTL Testing Technology Co., Ltd.

Master TRF: Dated 2011-01

Date of receipt of test item: June 9, 2025

Date of Test Date: June 9, 2025-August 12, 2025

Date of Issue: August 18, 2025

Result: **Pass**

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TEST REPORT

| | | |
|--------------------------|---------------------------|-----------------|
| Test Report No. : | CTL2506062031-WF01 | August 18, 2025 |
| Date of issue | | |

Equipment under Test : Camera

Sample No. : CTL2506062031

Model /Type : MDPT3301LE

Listed Models : MDPT2301LE, MDPT2302LE, MDPT2303LE, MDPT3302LE, MDPT3303LE, MDPT3401LE, MDPT3402LE, MDPT3403LE, MDPT5801LE, MDPT5802LE, MDPT5803LE, T10, T20, T30, T40, T50, T60, T12

Applicant : **MAYON ELECTRONIC TECHNOLOGY CO.,LTD**

Address : Area A01, 4th Floor, Building 1, No. 15, Pingbei 2nd Road, Nanping, Xiangzhou District, Zhuhai City, China

Manufacturer : **MAYON ELECTRONIC TECHNOLOGY CO.,LTD**

Address : Area A01, 4th Floor, Building 1, No. 15, Pingbei 2nd Road, Nanping, Xiangzhou District, Zhuhai City, China

| | |
|--------------------|---------------|
| Test result | Pass * |
|--------------------|---------------|

*In the configuration tested, the EUT complied with the standards specified page 5.

The test results presented in this report relate only to the object tested.

This report shall not be reproduced, except in full, without the written approval of the issuing testing laboratory.

This device (product name: Camera) model name: MDPT3301LE, MDPT2301LE, MDPT2302LE, MDPT2303LE, MDPT3302LE, MDPT3303LE, MDPT3401LE, MDPT3402LE, MDPT3403LE, MDPT5801LE, MDPT5802LE, MDPT5803LE, T10, T20, T30, T40, T50, T60, T12 electrical, PCB, BOM are the same, only the appearance color, shell material and model are different, which does not affect the test results.

** Modified History **

| | Table of Contents | Page |
|---|-------------------|-----------|
| 1. SUMMARY | | 5 |
| 1.1. TEST STANDARDS | | 5 |
| 1.2. TEST DESCRIPTION | | 5 |
| 1.3. TEST FACILITY | | 6 |
| 1.4. STATEMENT OF THE MEASUREMENT UNCERTAINTY | | 6 |
| 2. GENERAL INFORMATION | | 8 |
| 2.1. ENVIRONMENTAL CONDITIONS | | 8 |
| 2.2. GENERAL DESCRIPTION OF EUT | | 8 |
| 2.3. DESCRIPTION OF TEST MODES | | 8 |
| 2.4. EQUIPMENTS USED DURING THE TEST | | 11 |
| 2.5. RELATED SUBMITTAL(S) / GRANT (S) | | 11 |
| 2.6. MODIFICATIONS | | 11 |
| 3. TEST CONDITIONS AND RESULTS | | 12 |
| 3.1. OUTPUT POWER | | 12 |
| 3.2. PEAK-TO-AVERAGE RATIO (PAR) | | 16 |
| 3.3. 99% & -26 dB OCCUPIED BANDWIDTH | | 18 |
| 3.4. BAND EDGE COMPLIANCE | | 19 |
| 3.5. SPURIOUS EMISSION | | 20 |
| 3.6. FREQUENCY STABILITY UNDER TEMPERATURE & VOLTAGE VARIATIONS | | 22 |
| 4. TEST SETUP PHOTOS OF THE EUT | | 24 |
| 5. PHOTOS OF THE EUT | | 26 |

1. SUMMARY

1.1. TEST STANDARDS

The tests were performed according to following standards:

[FCC Part 22: PRIVATE LAND MOBILE RADIO SERVICES.](#)

[ANSI/TIA/EIA-603-E March 2016: Land Mobile FM or PM Communications Equipment Measurement and Performance Standards.](#)

[FCC Part 2: FREQUENCY ALLOCATIONS AND RADIO TREATY MATTERS; GENERAL RULES AND REGULATIONS](#)

[KDB971168 D01:v03r01 MEASUREMENT GUIDANCE FOR CERTIFICATION OF LICENSED DIGITAL TRANSMITTERS](#)

[ANSI C63.26-2015 American National Standard for Compliance Testing of Transmitters Used in Licensed Radio Services](#)

1.2. Test Description

| Test Item | Section in CFR 47 | Result |
|--|-------------------------------|--------|
| RF Output Power | Part 2.1046 Part 22.913(a) | Pass |
| Peak-to-Average Ratio | Part 2.1046 Part 22.913(d) | Pass |
| 99% & -26 dB Occupied Bandwidth | Part 2.1049 Part 22.917(b) | Pass |
| Spurious Emissions at Antenna Terminal | Part 2.1051 Part 22.917(b) | Pass |
| Field Strength of Spurious Radiation | Part 2.1053 Part 22.917(b) | Pass |
| Out of band emission, Band Edge | Part 2.1051 Part 22.917(b) | Pass |
| Frequency stability | Part 2.1055 22.355 | Pass |

1.3. Test Facility

1.3.1 Address of the test laboratory

Shenzhen CTL Testing Technology Co., Ltd.

Floor 1-A, Baisha Technology Park, No. 3011, Shahexi Road, Nanshan, Shenzhen 518055 China

There is one 3m semi-anechoic chamber and two line conducted labs for final test. The Test Sites meet the requirements in documents ANSI C63.4 and CISPR 32/EN 55032 requirements.

1.3.2 Laboratory accreditation

The test facility is recognized, certified, or accredited by the following organizations:

CNAS-Lab Code: L7497

Shenzhen CTL Testing Technology Co., Ltd. has been assessed and proved to be in compliance with CNAS-CL01 Accreditation Criteria for Testing and Calibration Laboratories (identical to ISO/IEC 17025: 2005 General Requirements) for the Competence of Testing and Calibration Laboratories.

A2LA-Lab Cert. No. 4343.01

Shenzhen CTL Testing Technology Co., Ltd, EMC Laboratory has been accredited by A2LA for technical competence in the field of electrical testing, and proved to be in compliance with ISO/IEC 17025: 2005 General Requirements for the Competence of Testing and Calibration Laboratories and any additional program requirements in the identified field of testing.

IC Registration No.: 9618B

CAB identifier: CN0041

The 3m alternate test site of Shenzhen CTL Testing Technology Co., Ltd. EMC Laboratory has been registered by Innovation, Science and Economic Development Canada to test to Canadian radio equipment requirements with Registration No.: 9618B.

FCC-Registration No.: 399832

Designation No.: CN1216

Shenzhen CTL Testing Technology Co., Ltd. EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration 399832.

1.4. Statement of the measurement uncertainty

The data and results referenced in this document are true and accurate. The reader is cautioned that there may be errors within the calibration limits of the equipment and facilities. The measurement uncertainty was calculated for all measurements listed in this test report acc. to CISPR 16 - 4 „Specification for radio disturbance and immunity measuring apparatus and methods – Part 4: Uncertainty in EMC Measurements“ and is documented in the Shenzhen CTL Testing Technology Co., Ltd. quality system acc. to DIN EN ISO/IEC 17025. Furthermore, component and process variability of devices similar to that tested may result in additional deviation. The manufacturer has the sole responsibility of continued compliance of the device.

Hereafter the best measurement capability for CTL laboratory is reported:

| Test | Measurement Uncertainty | Notes |
|------------------------------|-------------------------|-------|
| Transmitter power Radiated | ±2.20 dB | (1) |
| Occupied Bandwidth | ±0.02ppm | (1) |
| Radiated Emission 30~1000MHz | ±4.08dB | (1) |
| Radiated Emission Above 1GHz | ±4.32dB | (1) |

| | | |
|--------------------------------------|---|-----|
| Conducted Disturbance0.15~30MHz | $\pm 2.96\text{dB}$ | (1) |
| 20dB Emission Bandwidth | $\pm 1.9\%$ | (1) |
| Carrier Frequency Separation | $\pm 1.9\%$ | (1) |
| Maximum Power Spectral Density Level | $\pm 0.98\text{ dB}$ | (1) |
| Number of Hopping Channel | $\pm 1.9\%$ | (1) |
| Time of Occupancy | $\pm 0.11\%$ | (1) |
| Max Peak Conducted Output Power | $\pm 0.98\text{ dB}$ | (1) |
| Band-edge Spurious Emission | $\pm 1.21\text{dB}$ | (1) |
| Conducted RF Spurious Emission | 9kHz-7GHz: $\pm 1.09\text{dB}$ 7GHz-26.5GHz: $\pm 3.27\text{dB}$ | (1) |

This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of $k=1.96$.

2. GENERAL INFORMATION

2.1. Environmental conditions

During the measurement the environmental conditions were within the listed ranges:

| | |
|---------------------|---------|
| Normal Temperature: | 25°C |
| Relative Humidity: | 55 % |
| Air Pressure: | 101 kPa |

2.2. General Description of EUT

| | | |
|-----------------------|---|----------------|
| Product Name: | Camera | |
| Model/Type reference: | MDPT3301LE | |
| Power supply: | Input: DC 5V/2A or DC 3.7V form battery | |
| Hardware version: | V3.7 | |
| Software version: | 2446.0.19.15 | |
| LTE Band 5 | | |
| Operation Band: | Band 5 | |
| Modulation Type: | QPSK, 16QAM | |
| Frequency range: | LTE Band 5(Channel Bandwidth:1.4MHz) | 824.7~848.3MHz |
| | LTE Band 5(Channel Bandwidth:3MHz) | 825.5~847.5MHz |
| | LTE Band 5(Channel Bandwidth:5MHz) | 826.5~846.5MHz |
| | LTE Band 5(Channel Bandwidth:10MHz) | 829~844MHz |
| Max. ERP: | LTE Band 5(Channel Bandwidth:1.4MHz) | 0.1194 W |
| | LTE Band 5(Channel Bandwidth:3MHz) | 0.1191 W |
| | LTE Band 5(Channel Bandwidth:5MHz) | 0.1180 W |
| | LTE Band 5(Channel Bandwidth:10MHz) | 0.1208 W |
| Emission Designator: | LTE Band 5(Channel Bandwidth:1.4MHz) | 1M12W7D |
| | LTE Band 5(Channel Bandwidth:3MHz) | 2M77W7D |
| | LTE Band 5(Channel Bandwidth:5MHz) | 4M58W7D |
| | LTE Band 5(Channel Bandwidth:10MHz) | 9M10W7D |
| Antenna Type: | External antenna | |
| Antenna Gain: | -1.78dBi | |

Note: For more details, refer to the user's manual of the EUT.

2.3. Description of Test Modes

Pre-Scan has been conducted to determine the worst-case mode from all possible combinations between available modulations, data rates, XYZ axis.

The worst-case was found when positioned as the table below, Following channel(s) was(were) selected for the final test as listed below.

| Band | Radiated Emission |
|------------|-------------------|
| LTE Band 5 | Y-plane |

| Test Item | Available Channel | Test Channel | Channel Bandwidth | Modulation | Mode |
|---------------------------------|-------------------|---------------------|-------------------|-------------|--|
| RF Output Power/ERP | 20407 to 20643 | 20407, 20525, 20643 | 1.4MHz | QPSK, 16QAM | 1 RB/0 RB Offset 1 RB/2 RB Offset 1 RB/5 RB Offset 3 RB/0 RB Offset 3 RB/2 RB Offset 3 RB/3 RB Offset 6 RB/0 RB Offset |
| | 20415 to 20635 | 20415, 20525, 20635 | 3MHz | QPSK, 16QAM | 1 RB/0 RB Offset 1 RB/7 RB Offset 1 RB/14 RB Offset 8 RB/0 RB Offset 8 RB/4 RB Offset 8 RB/7 RB Offset 15 RB/0 RB Offset |
| | 20425 to 20625 | 20425, 20525, 20625 | 5MHz | QPSK, 16QAM | 1 RB/0 RB Offset 1 RB/13 RB Offset 1 RB/24 RB Offset 12 RB/0 RB Offset 12 RB/6 RB Offset 12 RB/13 RB Offset 25 RB/0 RB Offset |
| | 20450 to 20600 | 20450, 20525, 20600 | 10MHz | QPSK, 16QAM | 1 RB/0 RB Offset 1 RB/25 RB Offset 1 RB/49 RB Offset 25 RB/0 RB Offset 25 RB/13 RB Offset 25 RB/25 RB Offset 50 RB/0 RB Offset |
| Peak-to-Average Ratio | 20407 to 20643 | 20407, 20525, 20643 | 1.4MHz | QPSK, 16QAM | 6 RB/0 RB Offset |
| | 20415 to 20635 | 20415, 20525, 20635 | 3MHz | QPSK, 16QAM | 15 RB/0 RB Offset |
| | 20425 to 20625 | 20425, 20525, 20625 | 5MHz | QPSK, 16QAM | 25 RB/0 RB Offset |
| | 20450 to 20600 | 20450, 20525, 20600 | 10MHz | QPSK, 16QAM | 50 RB/0 RB Offset |
| 99% & -26 dB Occupied Bandwidth | 20407 to 20643 | 20407, 20525, 20643 | 1.4MHz | QPSK, 16QAM | 6 RB/0 RB Offset |
| | 20415 to 20635 | 20415, 20525, 20635 | 3MHz | QPSK, 16QAM | 15 RB/0 RB Offset |
| | 20425 to 20625 | 20425, 20525, 20625 | 5MHz | QPSK, 16QAM | 25 RB/0 RB Offset |
| | 20450 to 20600 | 20450, 20525, 20600 | 10MHz | QPSK, 16QAM | 50 RB/0 RB Offset |
| Conducted Emission | 20407 to 20643 | 20407, 20525, 20643 | 1.4MHz | QPSK, 16QAM | 1 RB/0 RB Offset |
| | 20415 to 20635 | 20415, 20525, 20635 | 3MHz | QPSK, 16QAM | 1 RB/0 RB Offset |
| | 20425 to 20625 | 20425, 20525, 20625 | 5MHz | QPSK, 16QAM | 1 RB/0 RB Offset |
| | 20450 to 20600 | 20450, 20525, 20600 | 10MHz | QPSK, 16QAM | 1 RB/0 RB Offset |
| Radiated Emission | 20407 to 20643 | 20407, 20525, 20643 | 1.4MHz | QPSK | 1 RB/2 RB Offset |
| | 20425 to 20625 | 20425, 20525, 20625 | 5MHz | QPSK | 1 RB/12 RB Offset |
| | 20450 to 20600 | 20450, 20525, | 10MHz | QPSK | 1 RB/24 RB Offset |

| | | | | | |
|----------------------|----------------|------------------------|--------|----------------|--|
| | | 20600 | | | |
| Band Edge compliance | 20407 to 20643 | 20407, 20643 | 1.4MHz | QPSK, 16QAM | 1 RB/0 RB Offset 1 RB/5 RB Offset 6 RB/0 RB Offset |
| | 20415 to 20635 | 20415, 20635 | 3MHz | QPSK, 16QAM | 1 RB/0 RB Offset 1 RB/14 RB Offset 15 RB/0 RB Offset |
| | 20425 to 20625 | 20425, 20625 | 5MHz | QPSK, 16QAM | 1 RB/0 RB Offset 1 RB/24 RB Offset 25 RB/0 RB Offset |
| | 20450 to 20600 | 20450, 20600 | 10MHz | QPSK, 16QAM | 1 RB/0 RB Offset 1 RB/49 RB Offset 50 RB/0 RB Offset |
| Frequency stability | 20407 to 20643 | 20407, 20525, 20643 | 1.4MHz | QPSK, 16QAM | 6 RB/0 RB Offset |
| | 20415 to 20635 | 20415, 20525, 20635 | 3MHz | QPSK, 16QAM | 15 RB/0 RB Offset |
| | 20425 to 20625 | 20425, 20525, 20625 | 5MHz | QPSK, 16QAM | 25 RB/0 RB Offset |
| | 20450 to 20600 | 20450, 20525, 20600 | 10MHz | QPSK, 16QAM | 50 RB/0 RB Offset |

Note: This device was tested under all RB configurations and modulations. The worst case was found in QPSK modulation.

2.4. Equipments Used during the Test

| Test Equipment | Manufacturer | Model No. | Serial No. | Calibration Date | Calibration Due Date |
|-------------------------------------|----------------------|-----------|-------------------------|------------------|----------------------|
| LISN | R&S | ESH2-Z5 | 860014/010 | 2025/04/29 | 2026/04/28 |
| Limitator | ROHDE & SCHWARZ | ESH3-Z2 | 100408 | 2025/04/29 | 2026/04/28 |
| EMI Test Receiver | ROHDE & SCHWARZ | ESCI | 1166.5950.03 | 2025/04/29 | 2026/04/28 |
| Double cone logarithmic antenna | Schwarzbeck | VULB 9168 | 824 | 2023/02/13 | 2026/02/12 |
| EMI Test Receiver | R&S | ESCI | 1166.5950.03 | 2025/04/29 | 2026/04/28 |
| Spectrum Analyzer | Agilent | N9020A | US46220290 | 2025/04/29 | 2026/04/28 |
| Spectrum Analyzer | Keysight | N9020A | MY53420874 | 2025/04/29 | 2026/04/28 |
| Horn Antenna | Sunol Sciences Corp. | DRH-118 | A062013 | 2024/11/25 | 2027/11/24 |
| Active Loop Antenna | Da Ze | ZN30900A | / | 2024/04/30 | 2027/04/29 |
| WIDEBAND RADIO COMMUNICATION TESTER | RS | CMW500 | 1201.0002K5 0-107930-CD | 2025/04/29 | 2026/04/28 |
| Amplifier | MRT-AP01M06 | MRT | S-001 | 2025/04/29 | 2026/04/28 |
| Amplifier | Brief&Smart | LNA-4018 | 2104197 | 2025/04/30 | 2026/04/29 |
| Temperature/Humidity Meter | Ji Yu | MC501 | / | 2025/05/06 | 2026/05/05 |
| Spectrum Analyzer | RS | FSP | 1164.4391.38 | 2025/04/29 | 2026/04/28 |
| Test Software | | | | | |
| Name of Software | | | | Version | |
| TST-PASS | | | | V2.0 | |
| EZ_EMC(Below 1GHz) | | | | V1.1.4.2 | |
| EZ_EMC((Above 1GHz) | | | | V1.1.4.2 | |

2.5. Related Submittal(s) / Grant (s)

This submittal(s) (test report) is intended to comply with of the Part 22.

2.6. Modifications

No modifications were implemented to meet testing criteria.

3. TEST CONDITIONS AND RESULTS

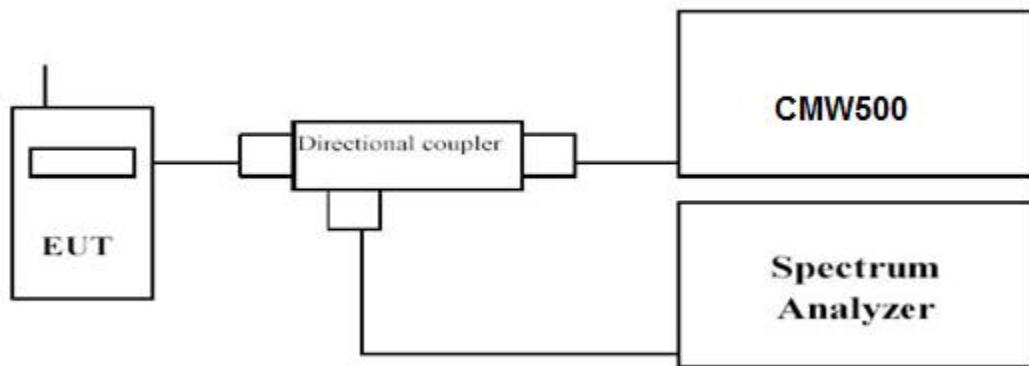
3.1. Output Power

LIMIT

7 Watts ERP.

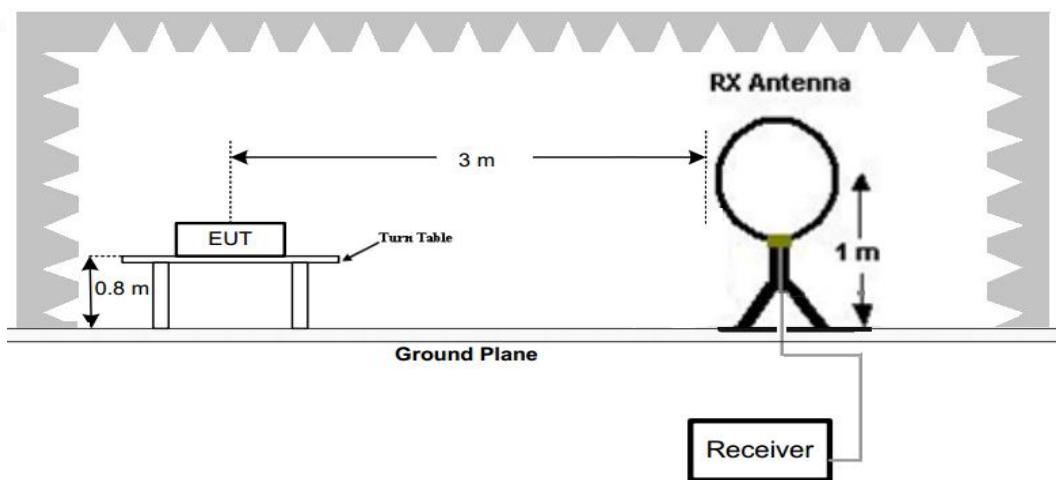
TEST CONFIGURATION

Conducted Power Measurement

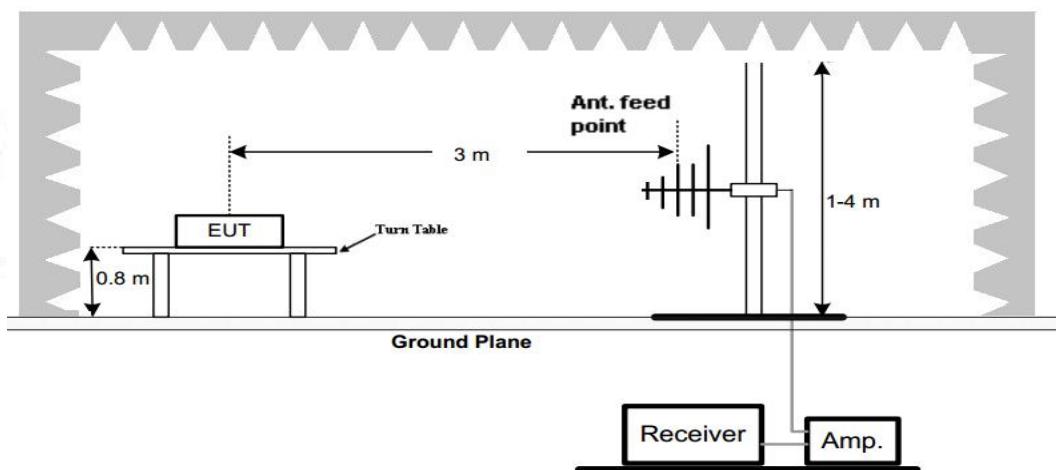


Radiated Power Measurement:

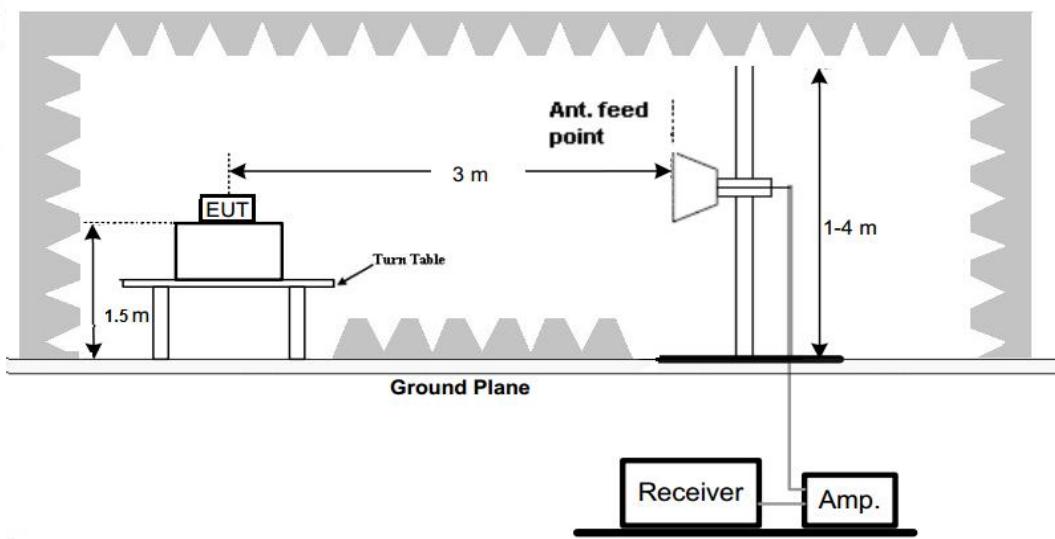
(A) Radiated Emission Test Set-Up, Frequency Below 30MHz



(B) Radiated Emission Test Set-Up, Frequency below 1000MHz



(C) Radiated Emission Test Set-Up, Frequency above 1000MHz



TEST PROCEDURE

The EUT was setup according to ANSI/TIA/EIA-603-E

Conducted Power Measurement:

- Place the EUT on a bench and set it in transmitting mode.
- Connect a low loss RF cable from the antenna port to a spectrum analyzer and CMW500 by a Directional Couple.
- EUT Communicate with CMW500 then selects a channel for testing.
- Add a correction factor to the display of spectrum, and then test.

Radiated Power Measurement:

- The EUT shall be placed at the specified height on a support, and in the position closest to normal use as declared by provider.
- The test antenna shall be oriented initially for vertical polarization and shall be chosen to correspond to the frequency of the transmitter
- The output of the test antenna shall be connected to the measuring receiver.
- The transmitter shall be switched on and the measuring receiver shall be tuned to the frequency of the transmitter under test.
- The test antenna shall be raised and lowered through the specified range of height until a maximum signal level is detected by the measuring receiver.
- The transmitter shall then be rotated through 360° in the horizontal plane, until the maximum signal level is detected by the measuring receiver.
- The test antenna shall be raised and lowered again through the specified range of height until a maximum signal level is detected by the measuring receiver.
- The maximum signal level detected by the measuring receiver shall be noted.
- The transmitter shall be replaced by a substitution antenna.
- The substitution antenna shall be orientated for vertical polarization and the length of the substitution antenna shall be adjusted to correspond to the frequency of the transmitter.

- k) The substitution antenna shall be connected to a calibrated signal generator.
- l) If necessary, the input attenuator setting of the measuring receiver shall be adjusted in order to increase the sensitivity of the measuring receiver.
- m) The test antenna shall be raised and lowered through the specified range of height to ensure that the maximum signal is received.
- n) The input signal to the substitution antenna shall be adjusted to the level that produces a level detected by the measuring receiver, that is equal to the level noted while the transmitter radiated power was measured, corrected for the change of input attenuator setting of the measuring receiver.
- o) The measurement shall be repeated with the test antenna and the substitution antenna orientated for horizontal polarization.
- p) The measure of the effective radiated power is the larger of the two levels recorded at the input to the substitution antenna, corrected for gain of the substitution antenna if necessary.
- q) Test site anechoic chamber refer to ANSI C63.4.

TEST RESULTS

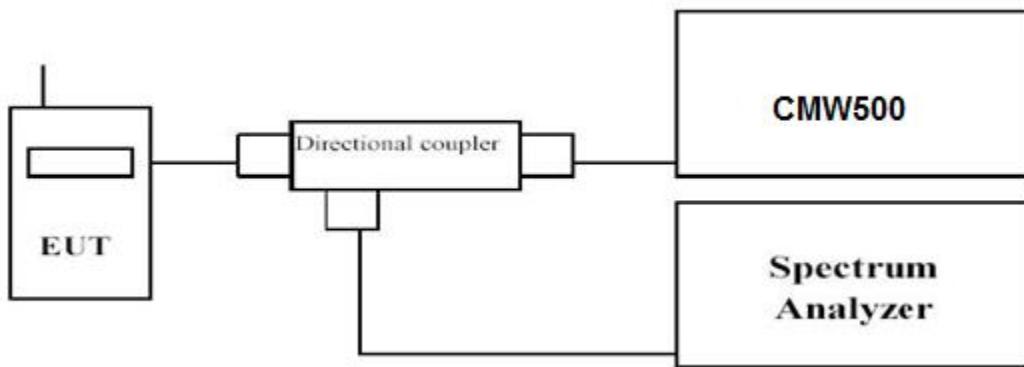
Raw data reference to Annex for FCC LTE Band 5.

3.2. Peak-to-Average Ratio (PAR)

LIMIT

The Peak-to-Average Ratio (PAR) of the transmission may not exceed 13 dB.

TEST CONFIGURATION



TEST PROCEDURE

1. Refer to instrument's analyzer instruction manual for details on how to use the power statistics/CCDF function;
2. Set resolution/measurement bandwidth \geq signal's occupied bandwidth;
3. Set the number of counts to a value that stabilizes the measured CCDF curve;
4. Set the measurement interval as follows:
 - 1). for continuous transmissions, set to 1 ms,
 - 2). for burst transmissions, employ an external trigger that is synchronized with the EUT burst timing sequence, or use the internal burst trigger with a trigger level that allows the burst to stabilize and set the measurement interval to a time that is less than or equal to the burst duration.
5. Record the maximum PAPR level associated with a probability of 0.1%.

TEST RESULTS

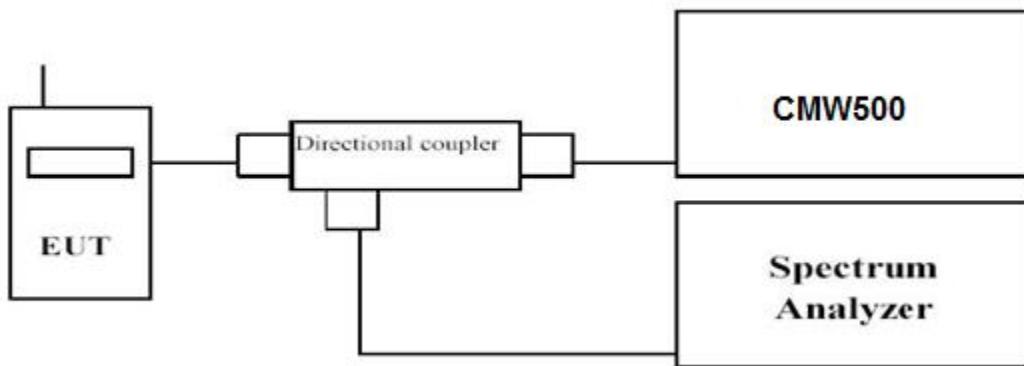
Raw data reference to Annex for FCC LTE Band 5.

3.3. 99% & -26 dB Occupied Bandwidth

LIMIT

N/A

TEST CONFIGURATION



TEST PROCEDURE

The transmitter output was connected to a calibrated coaxial cable and coupler, the other end of which was connected to a spectrum analyzer. The occupied bandwidth was measured with the spectrum analyzer at low, middle and high channel in each band. The -26dBc Emission bandwidth was also measured and recorded.

Set RBW was set to about 1% of emission BW, $VBW \geq 3$ times RBW.

-26dBc display line was placed on the screen (or 99% bandwidth), the occupied bandwidth is the delta frequency between the two points where the display line intersects the signal trace.

TEST RESULTS

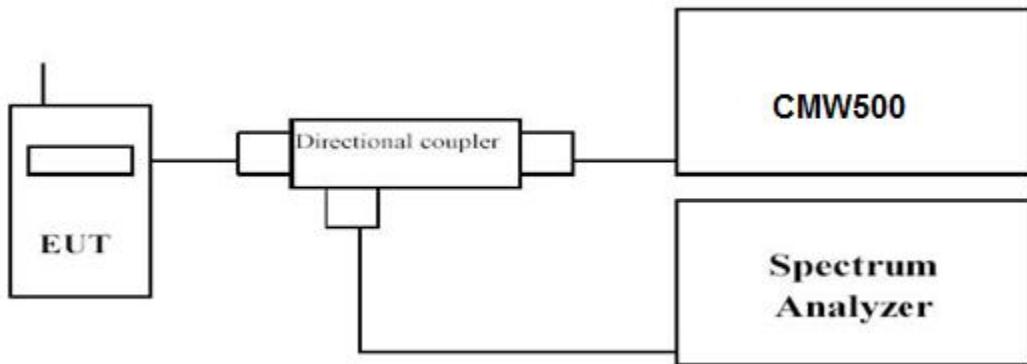
Raw data reference to Annex for FCC LTE Band 5.

3.4. Band Edge compliance

LIMIT

Per FCC §24.238 the power of any emission outside of the authorized operating frequency ranges must be attenuated below the transmitting power (P) by a factor of at least $43 + 10\log(P)$ dB.

TEST CONFIGURATION



TEST PROCEDURE

1. The transmitter output port was connected to base station.
2. The RF output of EUT was connected to the power meter by RF cable and attenuator, the path loss was compensated to the results for each measurement.
3. Set EUT at maximum power through base station.
4. Select lowest and highest channels for each band and different modulation.
5. Measure Band edge using RMS (Average) detector by spectrum

TEST RESULTS

Raw data reference to Annex for FCC LTE Band 5.

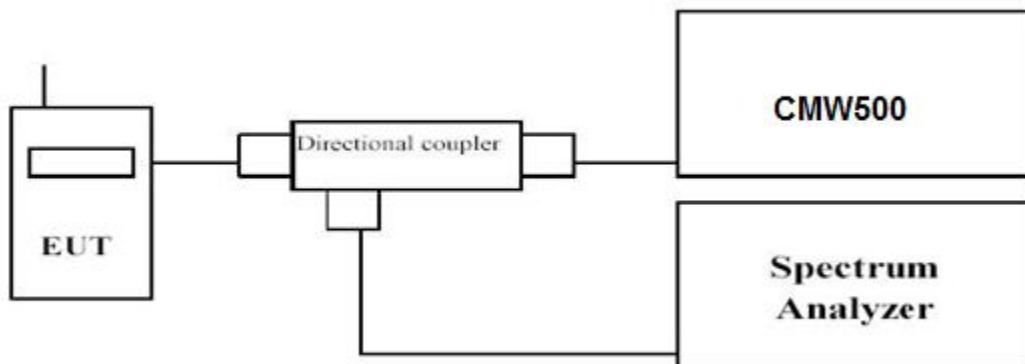
3.5. Spurious Emission

LIMIT

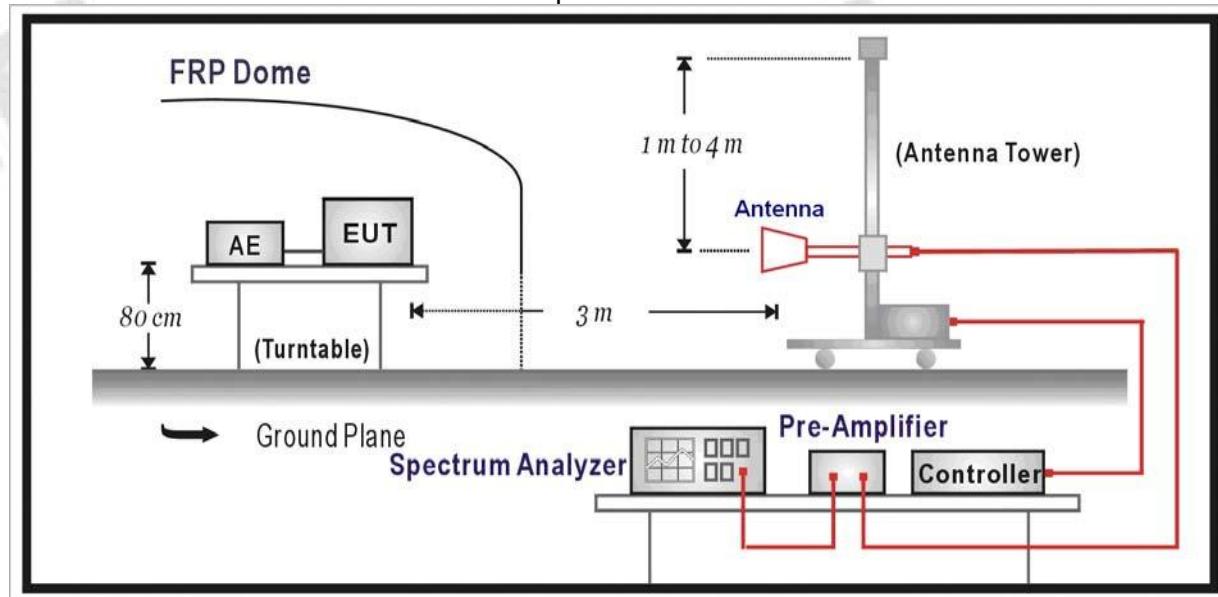
Per FCC §24.238, the power of any emission outside of the authorized operating frequency ranges must be attenuated below the transmitting power (P) by a factor of at least $43 + 10\log(P)$ dB.

TEST CONFIGURATION

Conducted Spurious Measurement:



Radiated Spurious Measurement:



TEST PROCEDURE

The EUT was setup according to ANSI/TIA/EIA-603-E

Conducted Spurious Measurement:

- Place the EUT on a bench and set it in transmitting mode.
- Connect a low loss RF cable from the antenna port to a spectrum analyzer and CMW500 by a Directional Coupler.
- EUT Communicate with CMW500 then selects a channel for testing.
- Add a correction factor to the display of spectrum, and then test.
- The resolution bandwidth of the spectrum analyzer was set sufficient scans were taken to show the out of band Emission if any up to 10th harmonic.

Radiated Spurious Measurement:

- a. The EUT shall be placed at the specified height on a support, and in the position closest to normal use as declared by provider.
- b. The test antenna shall be oriented initially for vertical polarization and shall be chosen to correspond to the frequency of the transmitter
- c. The output of the test antenna shall be connected to the measuring receiver.
- d. The transmitter shall be switched on and the measuring receiver shall be tuned to the frequency of the transmitter under test.
- e. The test antenna shall be raised and lowered through the specified range of height until a maximum signal level is detected by the measuring receiver.
- f. The transmitter shall then be rotated through 360° in the horizontal plane, until the maximum signal level is detected by the measuring receiver.
- g. The test antenna shall be raised and lowered again through the specified range of height until a maximum signal level is detected by the measuring receiver.
- h. The maximum signal level detected by the measuring receiver shall be noted.
- i. The transmitter shall be replaced by a substitution antenna.
- j. The substitution antenna shall be orientated for vertical polarization and the length of the substitution antenna shall be adjusted to correspond to the frequency of the transmitter.
- k. The substitution antenna shall be connected to a calibrated signal generator.
- l. If necessary, the input attenuator setting of the measuring receiver shall be adjusted in order to increase the sensitivity of the measuring receiver.
- m. The test antenna shall be raised and lowered through the specified range of height to ensure that the maximum signal is received.
- n. The input signal to the substitution antenna shall be adjusted to the level that produces a level detected by the measuring receiver, that is equal to the level noted while the transmitter radiated power was measured, corrected for the change of input attenuator setting of the measuring receiver.
- o. The measurement shall be repeated with the test antenna and the substitution antenna orientated for horizontal polarization.
- p. The measure of the effective radiated power is the larger of the two levels recorded at the input to the substitution antenna, corrected for gain of the substitution antenna if necessary.
- q. The resolution bandwidth of the spectrum analyzer was set at 100 kHz for below 1GHz and 1MHz for above 1GHz. The frequency range was checked up to 10th harmonic.
- r. Test site anechoic chamber refer to ANSI C63.4.

TEST RESULTS

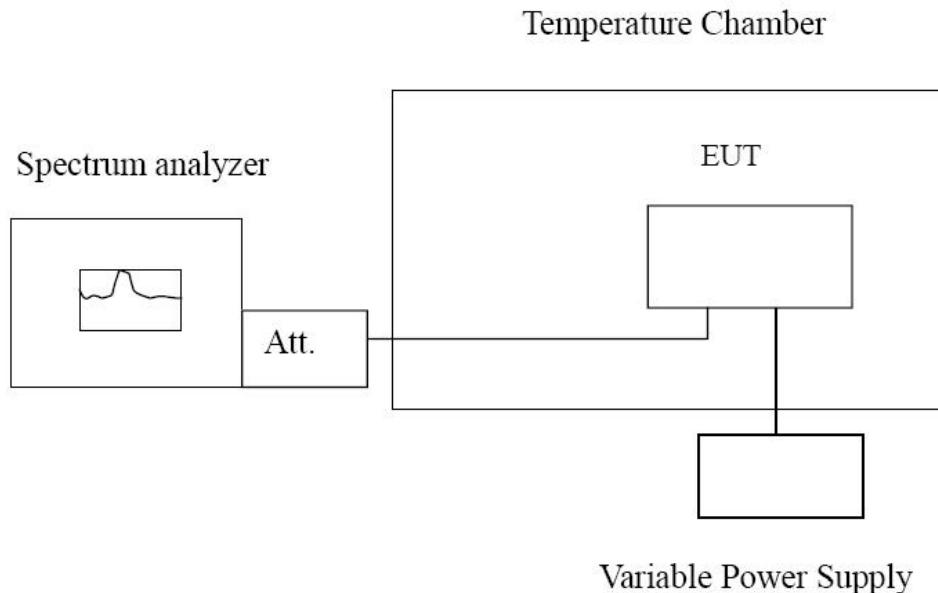
Raw data reference to Annex for FCC LTE Band 5.

3.6. Frequency Stability under Temperature & Voltage Variations

LIMIT

According to §24.235, §2.1055 requirement, the frequency stability shall be sufficient to ensure that the fundamental emissions stay within the authorized bands of operation and should not exceed 2.5ppm.

TEST CONFIGURATION



TEST PROCEDURE

The EUT was setup according to ANSI/TIA/EIA-603-E

Frequency Stability under Temperature Variations:

In order to measure the carrier frequency under the condition of AFC lock, it is necessary to make measurements with the EUT in a "call mode". This is accomplished with the use of R&S CMW500 DIGITAL RADIO COMMUNICATION TESTER.

1. Measure the carrier frequency at room temperature.
2. Subject the EUT to overnight soak at -30°C.
3. With the EUT, powered via nominal voltage, connected to the CMW500 and in a simulated call on middle channel for LTE Band 5, measure the carrier frequency. These measurements should be made within 2 minutes of Powering up the EUT, to prevent significant self-warming.
4. Repeat the above measurements at 10°C increments from -30°C to +50°C. Allow at least 1.5 hours at each temperature, unpowered, before making measurements.
5. Re-measure carrier frequency at room temperature with nominal voltage. Vary supply voltage from minimum voltage to maximum voltage, in 0.1 Volt increments re-measuring carrier frequency at each voltage. Pause at nominal voltage for 1.5 hours unpowered, to allow any self-heating to stabilize, before continuing.
6. Subject the EUT to overnight soak at +50°C.
7. With the EUT, powered via nominal voltage, connected to the CMW500 and in a simulated call on the centre channel, measure the carrier frequency. These measurements should be made within 2 minutes of Powering up the EUT, to prevent significant self-warming.
8. Repeat the above measurements at 10 °C increments from +50°C to -30°C. Allow at least 1.5 hours at each temperature, unpowered, before making measurements
9. At all temperature levels hold the temperature to +/- 0.5°C during the measurement procedure.

Frequency Stability under Voltage Variations:

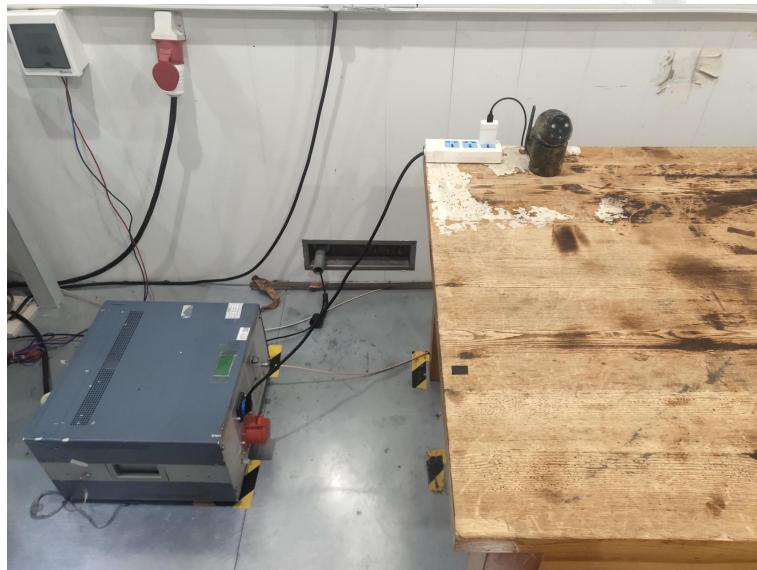
Set chamber temperature to 20°C. Use a variable AC power supply / DC power source to power the EUT and set the voltage to rated voltage. Set the spectrum analyzer RBW low enough to obtain the desired frequency resolution and recorded the frequency.

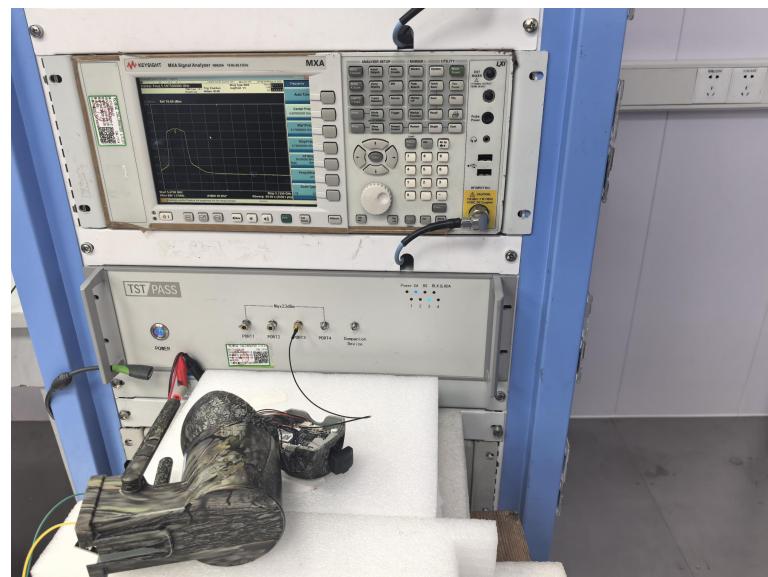
Reduce the input voltage to specify extreme voltage variation ($\pm 15\%$) and endpoint, record the maximum frequency change.

TEST RESULTS

Raw data reference to Annex for FCC LTE Band 5.

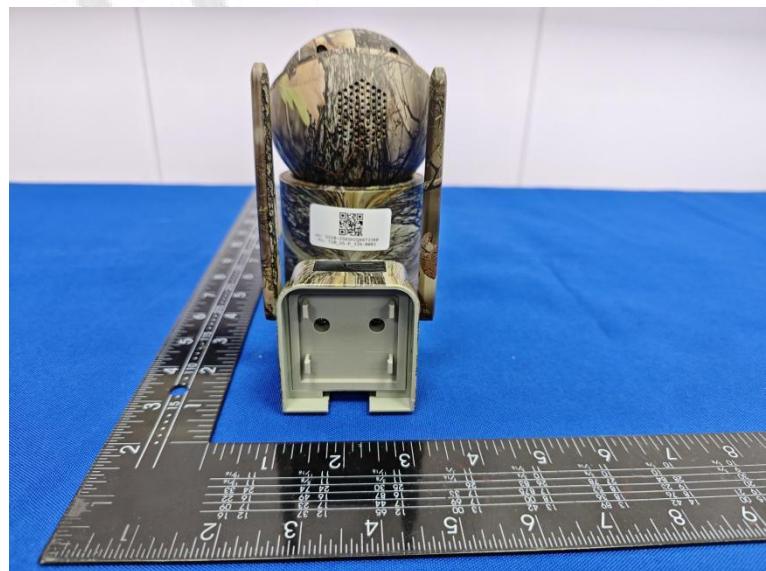
4. Test Setup Photos of the EUT





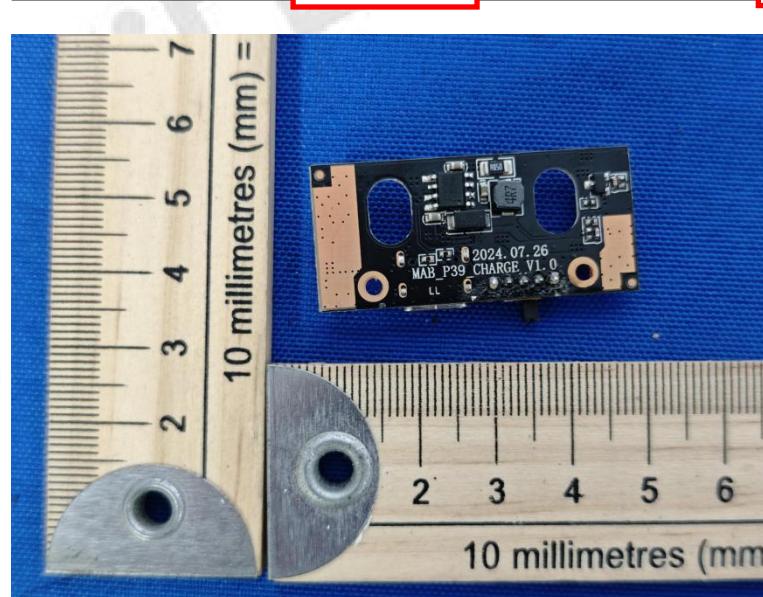
5. Photos of the EUT

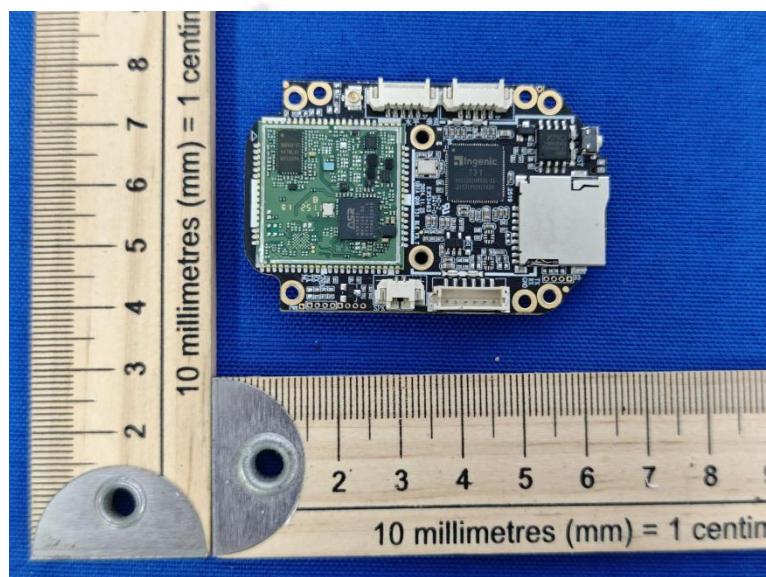
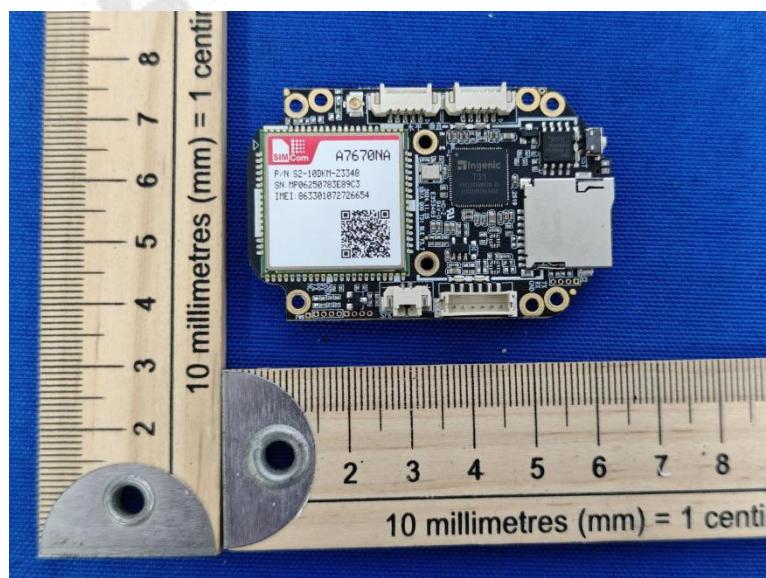
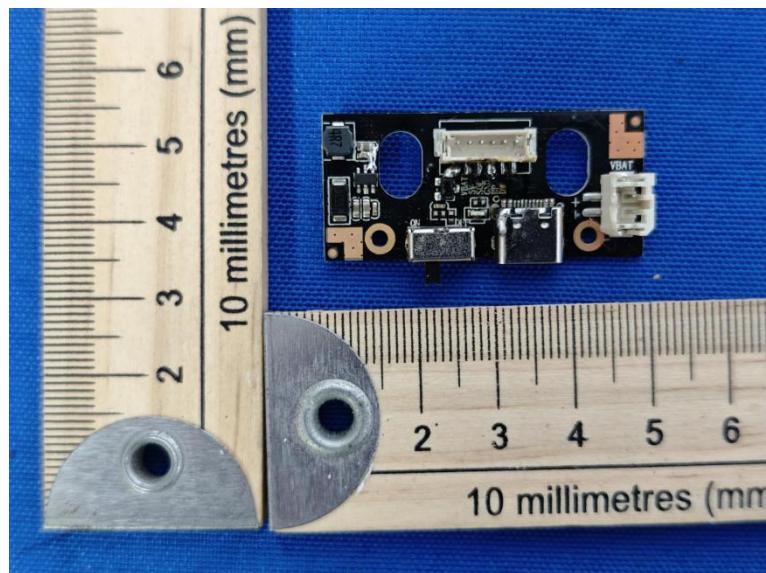
External Photos of EUT

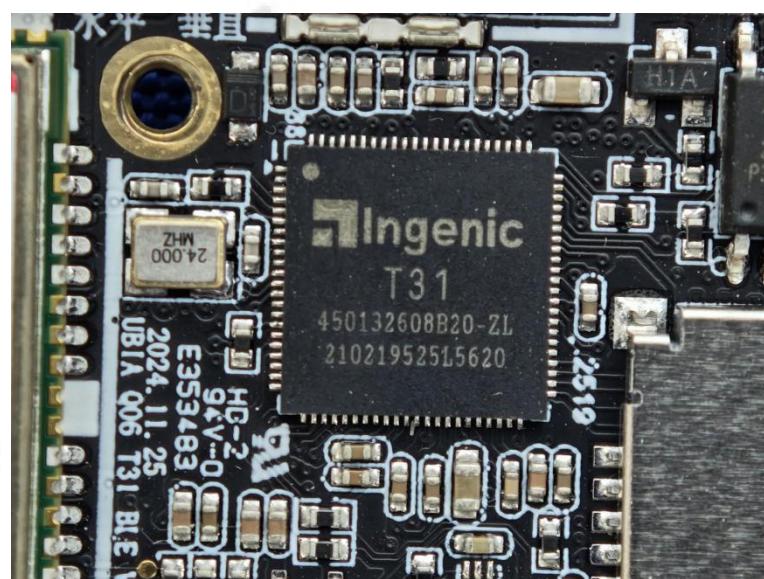
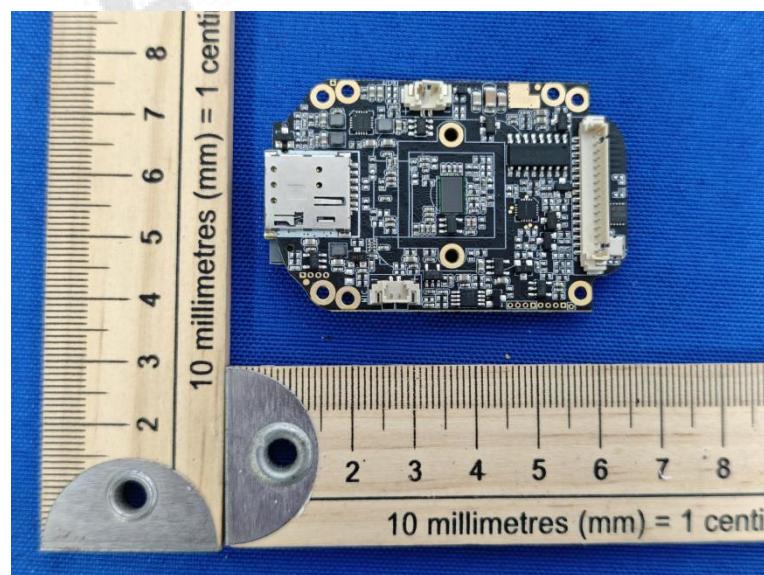
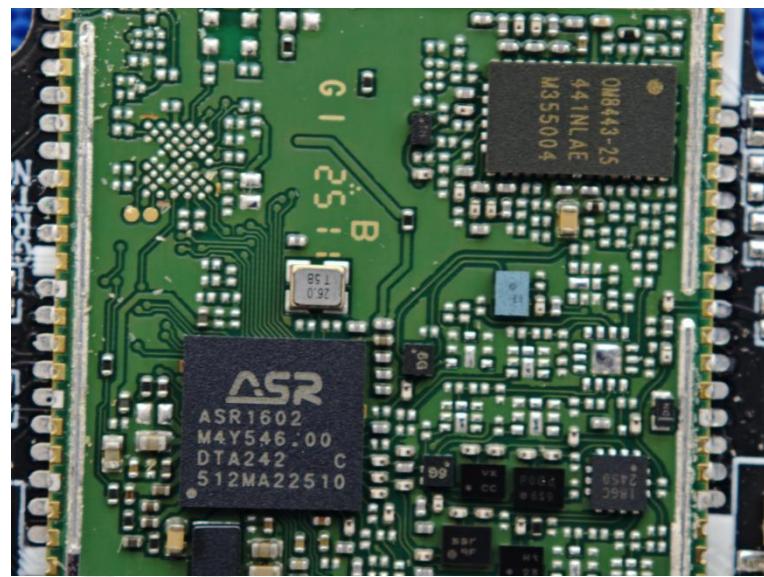


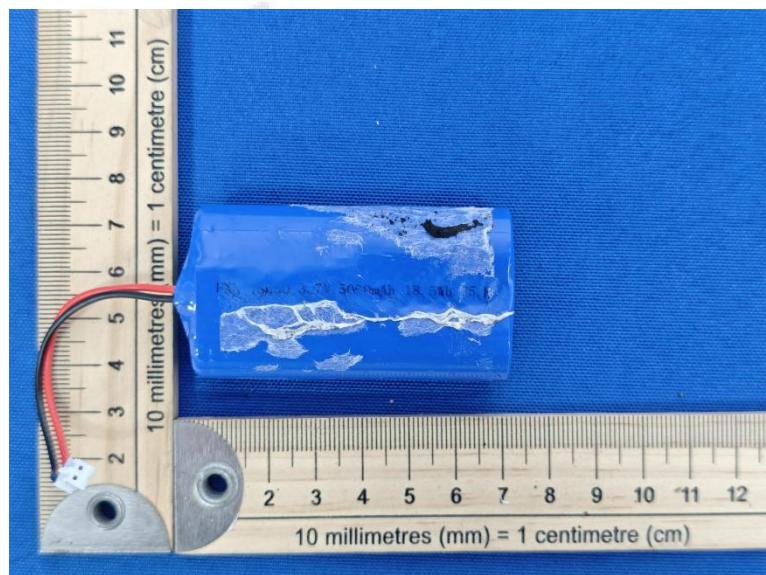
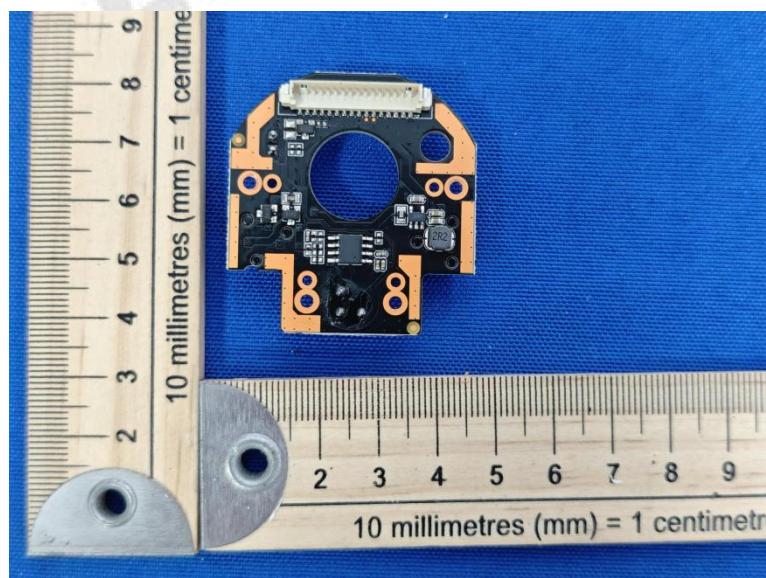
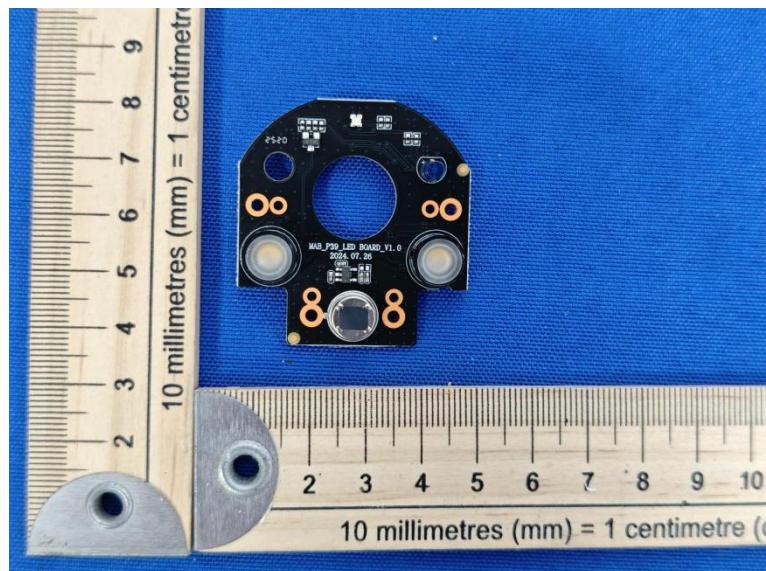




Internal Photos of EUT









***** End of Report *****